

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT  
(IECEE) CB SCHEME

CB TEST CERTIFICATE

Product LED driver

Name and address of the applicant Signify Netherlands B.V.  
High Tech Campus 48, 5656 AE Eindhoven,  
The Netherlands

Name and address of the manufacturer Signify Netherlands B.V.  
High Tech Campus 48, 5656 AE Eindhoven,  
The Netherlands

Name and address of the factory ☒ Additional information on page 2

Note: When more than one factory, please report on page 2

Ratings and principal characteristics Xitanium Dim 150W 0.7A 1-10V 230V Y:  
Un: 220-240 VAC; fn: 50/60 Hz; In: 0,6-0,83 Aac; Pin: 165W; PF: 0,98; Iout: 0,7  
Adc; Uout: 96-214 Vdc, 320 Vdc Max.; Pout: 150W; tc: 80 °C; ta: -40...+55 °C;  
built-in

Xitanium Dim 150W 1.05A 1-10V 230V Y:  
Un: 220-240 VAC; fn: 50/60 Hz; In: 0,6-0,83 Aac; Pin: 165W; PF: 0,98; Iout:  
1,05 Adc; Uout: 62-142 Vdc, 220 Vdc Max.; Pout: 150W;  
tc: 80 °C; ta: -40...+55 °C; built-in

Xitanium Dim 100W 0.7A 1-10V 230V Y:  
Un: 220-240 VAC; fn: 50/60 Hz; In: 0,4-0,56 Aac; Pin: 112W; PF: 0,95; Iout: 0,7  
Adc; Uout: 64-143 Vdc, 220 Vdc Max.; Pout: 100W;  
tc: 80 °C; ta: -40...+55 °C; built-in

Xitanium Dim 100W 1.05A 1-10V 230V Y:  
Un: 220-240 VAC; fn: 50/60 Hz; In: 0,4-0,56 Aac; Pin: 112W; PF: 0,95; Iout:  
1,05 Adc; Uout: 42-95 Vdc, 170 Vdc Max.; Pout: 100W;  
tc: 80 °C; ta: -40...+55 °C; built-in

Trademark (if any) PHILIPS

Customer's Testing Facility (CTF) Stage used CTF Stage 3

Model / Type Ref. Xitanium Dim 150W 0.7A 1-10V 230V Y  
Xitanium Dim 150W 1.05A 1-10V 230V Y  
Xitanium Dim 100W 0.7A 1-10V 230V Y  
Xitanium Dim 100W 1.05A 1-10V 230V Y

Additional information (if necessary may also be reported on page 2) ☐ Additional information on page 2

This CB Test Certificate is issued by the National Certification Body

DEKRA Certification B.V.  
Meander 1051, NL-6825 MJ Arnhem, Netherlands

 DEKRA



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A sample of the product was tested and found  
to be in conformity with

IEC 61347-1:2015, IEC 61347-1:2015/AMD1:2017, IEC 61347-2-13:2014, IEC 61347-2-  
13:2014/AMD1:2016, IEC 62384:2006, IEC 62384:2006/AMD1:2009

National differences:

EU Group Differences

6066769.50 and 6066769.51

As shown in the Test Report Ref. No. which  
forms part of this Certificate

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Date: 2020-01-20

Signature: Kate Xu



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Additional factory

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DEKRA Certification B.V.  
Meander 1051, NL-6825 MJ Arnhem, Netherlands



Date: 2020-01-20

Signature: Kate Xu

A handwritten signature in black ink, appearing to read 'Kate Xu', is written over the printed name.

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